

## BEST AVAILABLE COPY PATENT NUMBER and ISSUE DATE

U.S. UTILITY Patent Application

IIIII		n de la maga de		- 1 × 2			
-	APPL NUM	FILING DATE	CLASS SUBCLA	ASS GAU	EXAMINER	/+	
-	10064475	07/18/2002	327 726		examiner Bir	t i	
-	**APPLICANT	**APPLICANTS: Chen Wang-Jin; Fan Chen-Teng; Huang Cheng-I;					
			THE ASS				
		•					
				,			
	**CONTINUING DATA VERIFIED:						
-							
-			·				
						1	
	** FOREIGN AI	PPLICATIONS VE	RIFIED:				
			<del> </del>				
		OT PUBLISH 🖵		SCIND -			
	Foreign priority claim 35 USC 119 condition	ons met	☐ yes ☐ no ☐ yes ☐ no	1	TORNEY DOCKET NO		
Verified and Acknowledged Examiners's initials FTCP0003USA							
TITLE: Mux scan cell with delay circuit for reducing hold-time violations U.S.DEPT. OF COMM.PAT. & TM-PTO-436L(Rev. 12-94)							
0	TICE OF ALLOWA	ANCE MAILED					
_					× CLAIMS AL	in acc	
		* * * * * * * * * * * * * * * * * * * *	Assistant Examir	ner 🦸	Total Claims	Print Claim for O.G	
·	ISSUE Ount Due D		***************************************		DRAWI		
•		Paid 🔅 🧎			Sheets Drwg. Figs.Di	wg. Print Fig.	
_		3 3 13	Pr	imary Examiner			
	TERMIN	VAI	PREPARED	* * * *	Application Examin		
		ISCLAMER	WARNING: The in	nformation disclose	eri herein may be restricte	4	
	DISCLAMER  WARNING: The information disclosed herein may be restricted.  Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368, Possession outside the U.S. Patent & Trademark						
_	Office is restricted to authorized employees and contractors only.						
	FILED WITH: DISK (CRF) CD-ROM						
	(Attached in pocket on right inside flap)						